

**Notice of References Cited**

Application/Control No.

10/767,541

Applicant(s)/Patent Under  
Reexamination  
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Examiner

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Art Unit

1771

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,160,776	11-1992	Li et al.	428/109
	<del>C</del>	<del>US-</del>	<del></del>	<del></del>	<del></del>
	D	US-			
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	F	US-			
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**NON-PATENT DOCUMENTS**

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*Pet h*  
4/24/07